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Application/Control No.	Applicant(s)/Patent us Reexamination	nder
10/802,899	YAMADA, SHINICHI	
Examiner	Art Unit	
Lan Nguyen	3683	

SEARCHED				
Class	Subclass	Date	Examiner	
188	306 - 310	8/21/06	XLN	
	Z90, 130			
	294			
280	272			
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Uplata	all	4/12/07	XLN	

INTERFERENCE SEARCHED				
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	DATE	EXMR
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Update inventor Search	12/18/06	xN
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No d.p.		